Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/672,035	KANG ET AL.	
Examiner	Art Unit	
Thien F. Tran	2811	

SEARCHED			
Class	Subclass	Date	Examiner
257	529, 530 209, 665	8/10/2005	π
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	8/10/2005	π
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